

SDT03N04-VB Datasheet

Power MOSFET

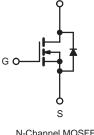
PRODUCT SUMMA	RY	
V _{DS} (V)	650)
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	8.4
Q _g (Max.) (nC)	18	
Q _{gs} (nC)	3.0	
Q _{gd} (nC)	8.9	
Configuration	Sing	le

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	650	V	
Gate-Source Voltage		V _{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $\frac{T_{C} = 25 \circ 0}{T_{C} = 100 \circ 0}$		1.2	А	
	$T_{\rm C} = 100^{\circ}$	C ^U	0.8		
Pulsed Drain Current ^a		I _{DM}	4.8		
Linear Derating Factor			0.33	W/°C	
Linear Derating Factor (PCB Mount) ^e			0.020	VV/ C	
Single Pulse Avalanche Energy ^b		E _{AS}	74	mJ	
Repetitive Avalanche Current ^a		I _{AR}	2.0	А	
Repetitive Avalanche Energy ^a		E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C = 25 °C	D	3	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C	- P _D	0.02		
Peak Diode Recovery dV/dt ^c		dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150		
Soldering Recommendations (Peak Temperature)	for 10 s		260 ^d		

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 37 mH, $R_g = 25 \Omega$, $I_{AS} = 2.0 \text{ A}$ (see fig. 12). c. $I_{SD} \le 2.0 \text{ A}$, dl/dt $\le 40 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$. d. 1.6 mm from case. e. When mounted on 1" square PCB (FR-4 or G-10 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RAT	NGS				
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	-	110	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.0	

Note

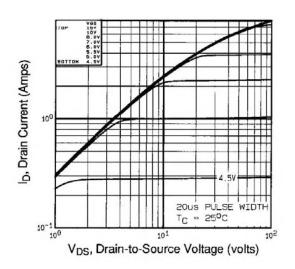
a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I _D = 1 mA	-	0.88	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
		V _{DS} =	= 600 V, V _{GS} = 0 V	-	-	100	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 480 V	/, V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.2 A ^b	-	8.4	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 1.2 A	1.4	-	-	S
Dynamic					•	•	
Input Capacitance	C _{iss}		$V_{GS} = 0 V$.	-	350	-	
Output Capacitance	Coss		$V_{GS} = 0 V,$ $V_{DS} = -25 V,$		48	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	8.6	-	
Total Gate Charge	Qg			-	-	18	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	I _D = 2.0 A, V _{DS} = 360 V, see fig. 6 and 13 ^b	-	-	3.0	nC
Gate-Drain Charge	Q _{gd}		see lig. o and ro	-	-	8.9	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	- V =	= 300 V, I _D = 2.0 A,	-	23	-	
Turn-Off Delay Time	t _{d(off)}	$R_g = 18 \Omega$, $R_D = 135 \Omega$, see fig. 10^{b}		-	30	-	ns
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	6 mm (0.25") f	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal Source Inductance	Ls	die contact		-	7.5	-	
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	2.0	A
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction		-	-	8.0	
Body Diode Voltage	V_{SD}	T _J = 25 °C	S, $I_S = 2.0 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 °C I	-200 dl/dt -100 A/mb	-	290	580	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 2.0 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	0.67	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



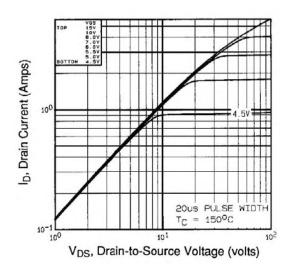


Fig. 2 - Typical Output Characteristics, $T_C = 150 \ ^{\circ}C$

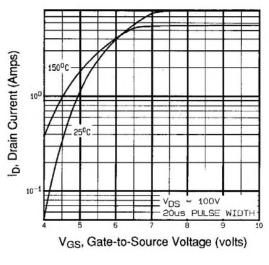


Fig. 3 - Typical Transfer Characteristics

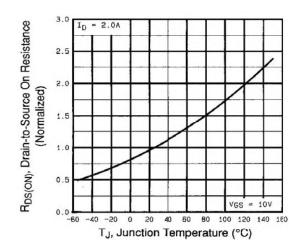


Fig. 4 - Normalized On-Resistance vs. Temperature



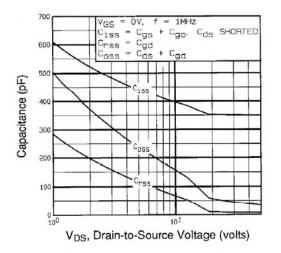
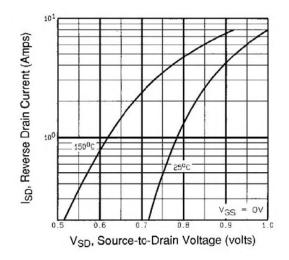


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





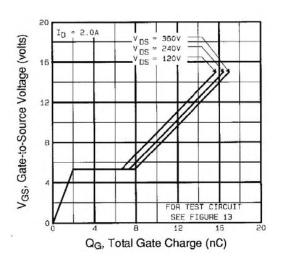


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

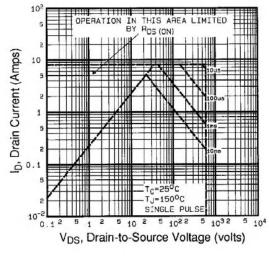


Fig. 8 - Maximum Safe Operating Area



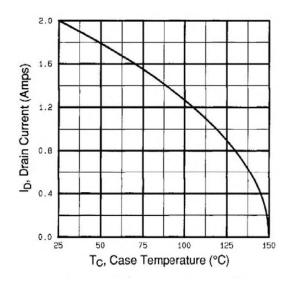


Fig. 9 - Maximum Drain Current vs. Case Temperature

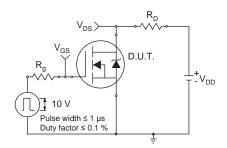


Fig. 10a - Switching Time Test Circuit

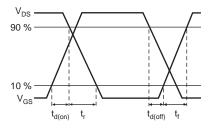
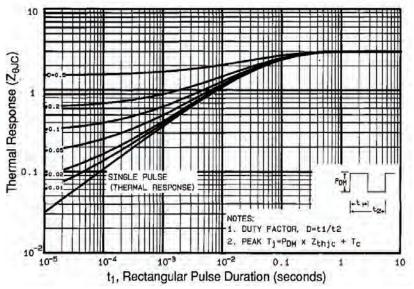


Fig. 10b - Switching Time Waveforms







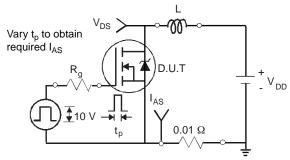


Fig. 12a - Unclamped Inductive Test Circuit

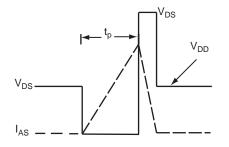


Fig. 12b - Unclamped Inductive Waveforms

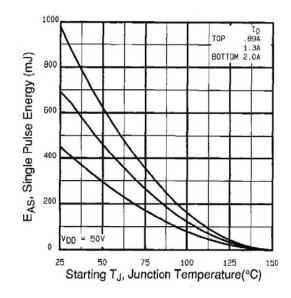


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

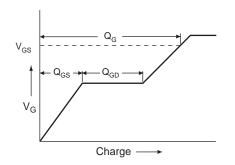


Fig. 13a - Basic Gate Charge Waveform

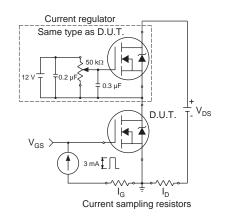
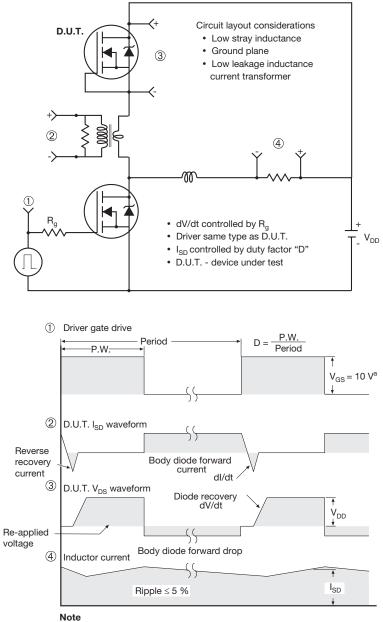


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

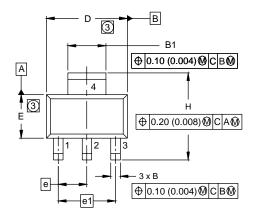


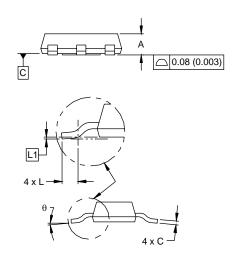
a. $V_{GS} = 5 \text{ V}$ for logic level devices

Fig. 14 - For N-Channel



SOT-223 (HIGH VOLTAGE)





	MILLI	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	1.55	1.80	0.061	0.071	
В	0.65	0.85	0.026	0.033	
B1	2.95	3.15	0.116	0.124	
С	0.25	0.35	0.010	0.014	
D	6.30	6.70	0.248	0.264	
E	3.30	3.70	0.130	0.146	
е	2.30 BSC		0.0905 BSC		
e1	4.60	BSC	0.181	BSC	
Н	6.71	7.29	0.264	0.287	
L	0.91	-	0.036	-	
L1	0.061 BSC		0.0024 BSC		
θ	-	10'	-	10'	

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension do not include mold flash.

4. Outline conforms to JEDEC outline TO-261AA.



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